

TRANSFER ELECTRON DEVICES

INTRODUCTION:

The application of two-terminal semiconductor devices at microwave frequencies has been increased usage during the past decades. The CW, average, and peak power outputs of these devices at higher microwave frequencies are much larger than those obtainable with the best power transistor. The common characteristic of all active two-terminal solid-state devices is their negative resistance. The real part of their impedance is negative over a range of frequencies. In a positive resistance the current through the resistance and the voltage across it are in phase. The voltage drop across a positive resistance is positive and a power of $(I^2 R)$ is dissipated in the resistance.

In a negative resistance, however, the current and voltage are out of phase by 180° . The voltage drop across a negative resistance is negative, and a power of $(-I^2 R)$ is generated by the power supply associated with the negative resistance. In positive resistances absorb power (passive devices), whereas negative resistances generate power (active devices). In this chapter the transferred electron devices (TEDs) are analyzed.

The differences between microwave transistors and transferred electron devices (TEDs) are fundamental. Transistors operate with either junctions or gates, but TEDs are bulk devices having no junctions or gates. The majority of transistors are fabricated from elemental semiconductors, such as silicon or germanium, whereas TEDs are fabricated from compound semiconductors, such as

gallium arsenide (GaAs), indium phosphide (InP), or cadmium telluride (CdTe).
Transistors operate

As "warm" electrons whose energy is not much greater than the thermal energy (0.026 eV at room temperature) of electrons in the semiconductors.

GUNN EFFECT DIODES – GaAs diode

Gunn effect diodes are named after J. B. Gunn who in 1963 discovered a periodic fluctuation of current passing through the n-type gallium arsenide when the applied voltage exceeded a certain critical value.

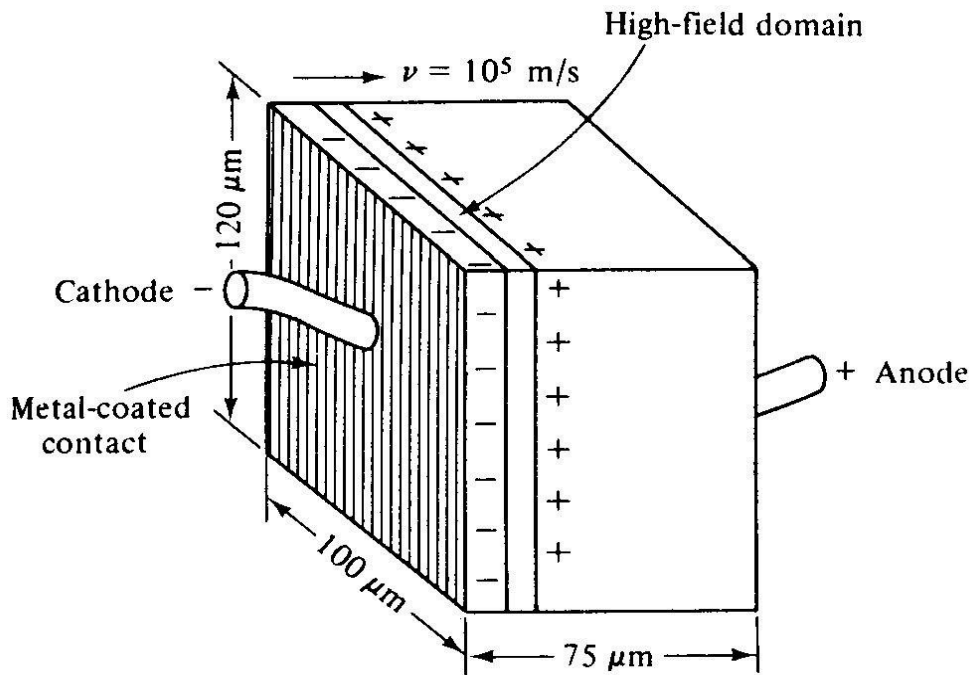
Shockley in 1954 suggested that the two terminal negative resistance devices using semiconductors had advantages over transistors at high frequencies.

In 1961, Ridley and Watkins described a new method for obtaining negative differential mobility in semiconductors. The principle involved is to heat carriers in a light mass, low mobility, higher energy sub band when they have a high temperature.

Finally Kroemer stated that the origin of the negative differential mobility is Ridley Watkins Hilsum's mechanism of electron transfer into the valleys that occur in conduction bands.

Gunn effect:

The below figure shows the diagram of a uniform n-type GaAs diode with ohmic contacts at the end surfaces. Gunn stated that "Above some critical voltage, corresponding to an electric field of 2000 to 4000 Volts/cm, the current in every specimen became a fluctuating function of time.



Gunn Diodes

Single piece of GaAs or InP and contains no junctions

Exhibits negative differential resistance

Applications:

low-noise local oscillators for mixers (2 to 140 GHz).

Low-power transmitters and wide band tunable sources

Continuous-wave (CW) power levels of up to several hundred mill watts can be obtained in the X-, Ku-, and Ka-bands. A power output of 30 mW can be achieved from commercially available devices at 94 GHz.

Higher power can be achieved by combining several devices in a power

Gunn oscillators exhibit very low dc-to-RF efficiency of 1 to 4%.

Gunn also discovered that the threshold electric field E_{th} varied with the length and type of material. He developed an elaborate capacitive probe for plotting the electric field distribution within a specimen of n-type GaAs of length $L = 210 \mu\text{m}$ and cross-sectional area $3.5 \times 10^{-3} \text{ cm}^2$ with a low-field resistance of 16Ω . Current instabilities occurred at specimen voltages above 59 V, which means that the threshold field is

$$E_{th} = \frac{V}{L} = \frac{59}{210 \times 10^{-6} \times 10^2} = 2810 \text{ volts/cm}$$

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